Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/591,976	Reexamination ROSSMANN ET	AL.
Examiner	Art Unit	
KENNETH J. WHITTINGTON	2858	Page 1 of 1

II S PATENT DOCUMENTS

	U.S. PATENT DOCUMENTS				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,969,988	11-2005	Kakuta et al.	324/207.25
*	В	US-4,752,733	06-1988	Petr et al.	324/225
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-		-	
	Т	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Demierre, Michel, IMPROVEMENTS OF CMOS HALL MICROSYSTEMS AND APPLICATIONS FOR ABSOLUTE ANGULAR POSITION MEASUREMENTS, University These for Institute of Microelectronics and Microsystems, dated September 2003.
	v	
	w	
	×	

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.